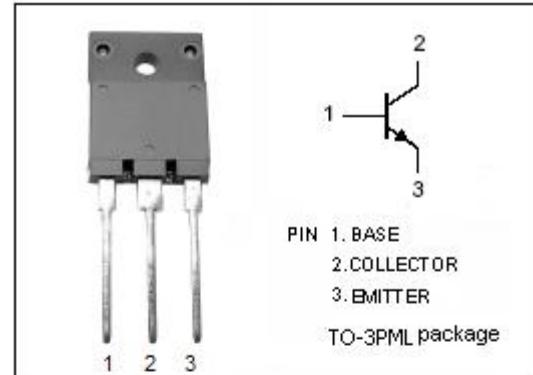




INCHANGE Semiconductor

**isc Silicon NPN Power Transistor****2SC3843****DESCRIPTION**

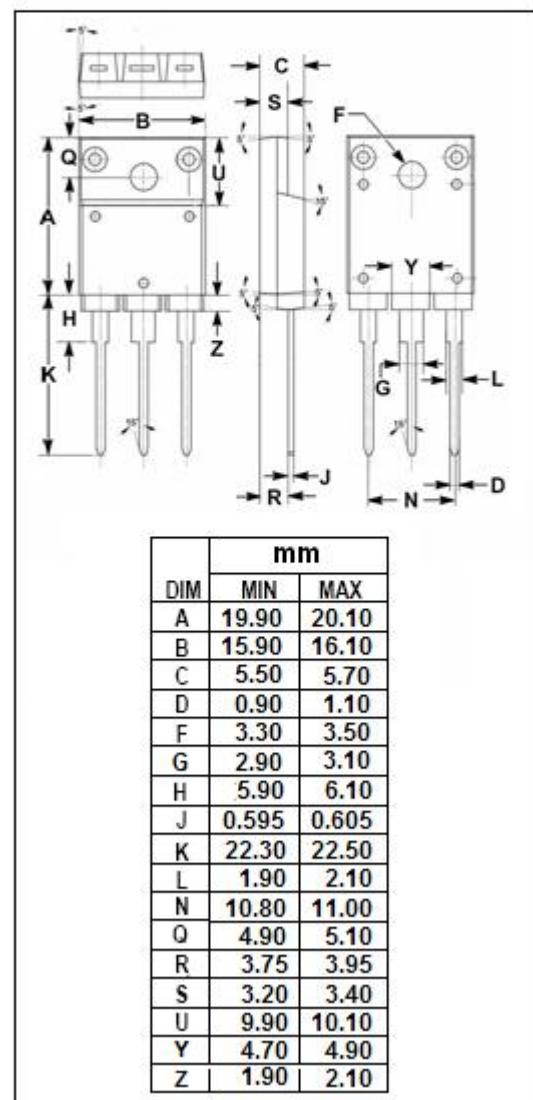
- High Breakdown Voltage
- High Switching Speed
- Wide Area of Safe Operation
- 100% avalanche tested
- Minimum Lot-to-Lot variations for robust device performance and reliable operation

**APPLICATIONS**

- Designed for silicon high speed transistor

**ABSOLUTE MAXIMUM RATINGS( $T_a=25^\circ\text{C}$ )**

SYMBOL	PARAMETER	VALUE	UNIT
$V_{CBO}$	Collector-Base Voltage	600	V
$V_{CEO}$	Collector-Emitter Voltage	450	V
$V_{EBO}$	Emitter-Base Voltage	7	V
$I_C$	Collector Current- Continuous	10	A
$I_{CM}$	Collector Current- Peak	20	A
$P_c$	Collector Power Dissipation @ $T_c=25^\circ\text{C}$	75	W
$T_J$	Junction Temperature	150	°C
$T_{stg}$	Storage Temperature Range	-55~150	°C



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**isc Silicon NPN Power Transistor****2SC3843****ELECTRICAL CHARACTERISTICS** $T_c=25^\circ C$  unless otherwise specified

SYMBOL	PARAMETER	CONDITIONS	MIN	TYP.	MAX	UNIT
$V_{CE(sat)}$	Collector-Emitter Saturation Voltage	$I_C = 6A; I_B = 1.2A$			1.0	V
$V_{BE(sat)}$	Base-Emitter Saturation Voltage	$I_C = 6A; I_B = 1.2A$			1.5	V
$I_{CBO}$	Collector Cutoff Current	$V_{CB} = 500V; I_E = 0$			100	$\mu A$
$I_{EBO}$	Emitter Cutoff Current	$V_{EB} = 6V; I_C = 0$			100	uA
$h_{FE}$	DC Current Gain	$I_C = 6A; V_{CE} = 5V$	10		30	
$f_T$	Current-Gain—Bandwidth Product	$I_E = 2A; V_{CE} = 10V$		28		MHz
$C_{OB}$	Output Capacitance	$I_E = 0; V_{CB} = 10V; f_{test} = 1.0MHz$		230		pF

## Switching times

$t_{on}$	Turn-on Time	$I_C = 6A; I_{B1} = 1.2A; I_{B2} = -1.2A$ $V_{CC} = 150V$			0.3	$\mu s$
$t_{stg}$	Storage Time				1.5	$\mu s$
$t_f$	Fall Time				0.2	$\mu s$